Notice of References Cited	Application/Control No. 10/681,622	Applicant(s)/Patent Under Reexamination CHAN ET AL.	
	Examiner Matthew F DeSanto	Art Unit 3763	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,738,661	05-2004	Nyhart, Jr., Eldon H.	604/20
X	B	US-6,348,042	02-2002	Warren, Jr., W. Lee	604/8
X	C	US-6,176,842	01-2001	Tachibana et al.	604/22
X	D	US-2001/0041870	11-2001	GILLIS et al.	604/164.09
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.